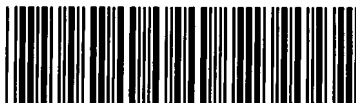


**Search Notes**

Application/Control No.

10/626,712

Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

MAEDA ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	241-245, 256-261, 263	6/16/2007	HP
359	204	6/16/2007	HP
372	107	6/16/2007	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	6/16/2007	HP